

welcome

wallonia electronics and communications measurements

## Electrical Characterization Facilities @ UCLouvain/ICTEAM

2019/03/19

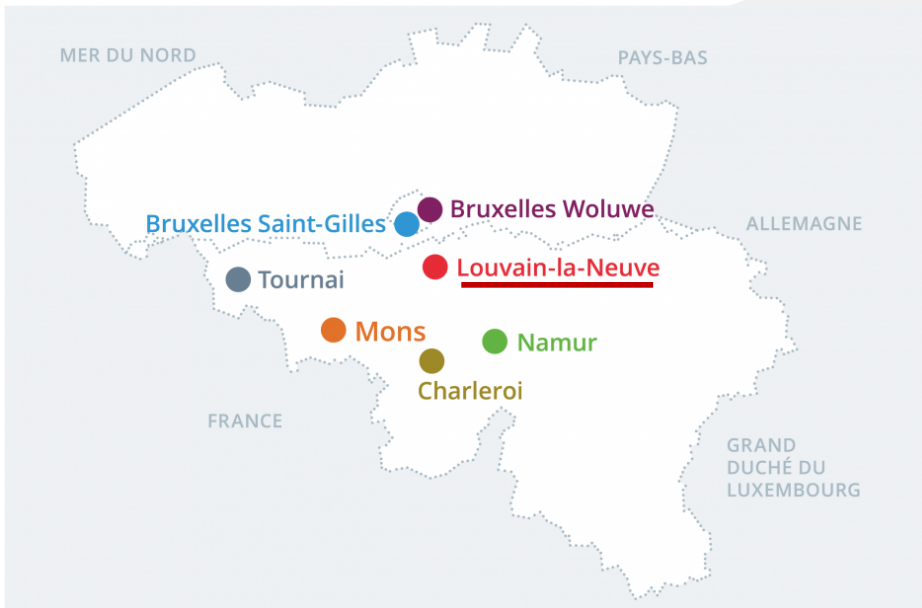
# WELCOME



**Wallonia Electronics and Communications Measurements**



**Localisation: 1348 Louvain-la-Neuve**



**Site web:**

<https://sites.uclouvain.be/icteam/welcome>

**UCLouvain – Université catholique de Louvain**



**SST – Sector of Science and Technology**



**ICTEAM – Institute of Information and Communication Technologies, Electronics and Applied Mathematics**



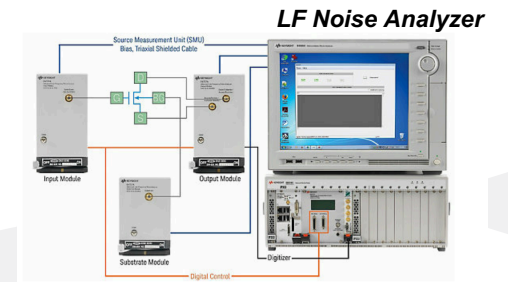
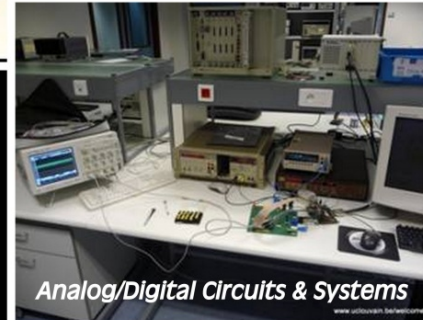
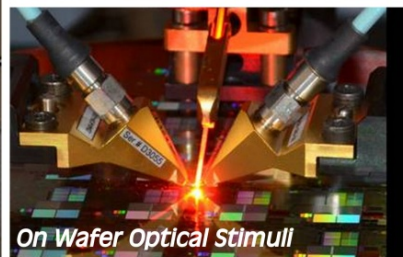
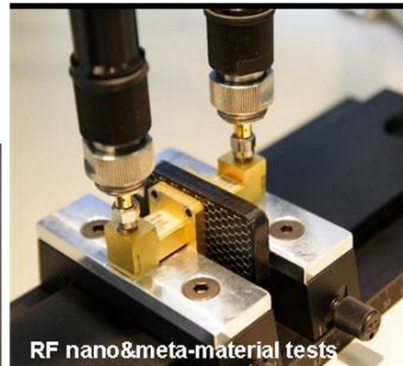
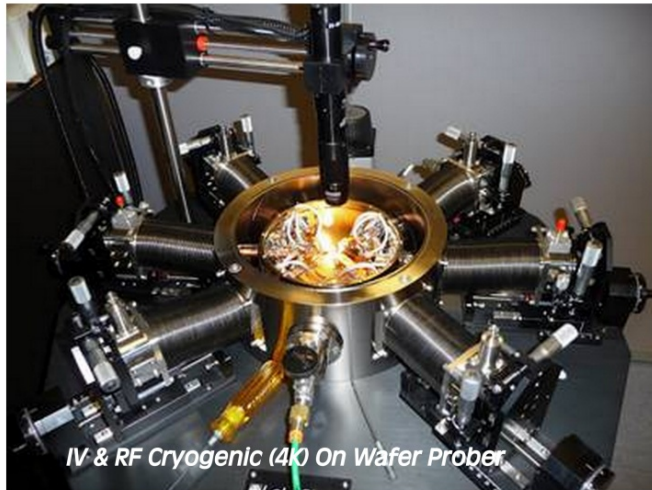
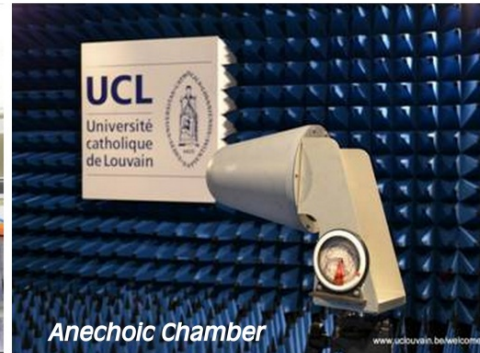
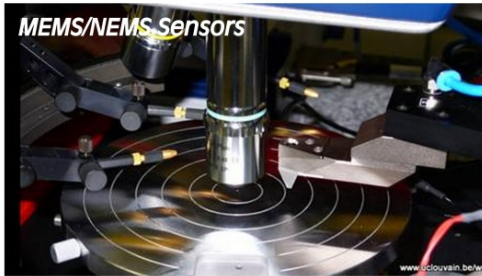
**WELCOME (for Research/Education/Industry)**

- ⇒ **350 m<sup>2</sup> state-of-the art facilities** for the electrical and electro-magnetic measurements on **materials, devices, sensors, circuits and systems levels**
- ⇒ **3 M€ invested over past 10 years**
- ⇒ **Built on the expertise of >10 promoters/research groups**
- ⇒ **About 135 users / year**



**Staff: 5 persons:** Platform Manager, Research Logistician, Engineer and 2 Technicians

# Platform Overview



**300mm Semi-Automatic Prober**



**900 Hz to 125 GHz VNA**



# Service proposal & technical specificities



## • Services proposal

### ☐ Test / analysis

- **Materials, electron devices and sensors**, from DC to 110 GHz, in the temperature range 4-600K
  - Tri- and Co-axial setups, on-wafer probe stations and VNAs, 1/f noise and RTN
  - Multi-port (up to 4 accesses) and multi-parametric characterization of passive and active devices (IV, CV, temperature-microwave, electro-mechanical, and magneto-electrical sweeps, ...), in small-signal and nonlinear regime
- **Analog/digital circuits and systems-in-package** ( $\mu$ controllers, smart cards, RFIDs, FPGAs)
  - Using ultra low current probes, mixed-signal and real-time oscilloscopes, analog waveform and digital pattern generators, vector signal generators with I/Q or digital modulation ...
- **RF hardware, protocols and channels for wireless and ultra-wideband communications**
  - Using Vector Network Analyzers, broadband antennas, channel sounders, in a free-space, multi-path or anechoic environment.

### ☐ Collaborative Research

- **Support to the research projects** (EC, NoE, H2020, Ecsel, ESA, RW, Innoviris, FNRS, EoS, ...)
- **Support to Spin-offs, SMEs, Valorization**
- **Links with other UCLouvain platforms** (Cyclotron, Winfab, Bio-Chemical, Robotic, ...)

### ☐ Support to Education (Master Thesis, Courses/Demos, PhD students, ....)

## • Remarkable equipment

### ✓ Various Probe stations:

- Semi-automatic MPI : 300mm, 20-300°C
- Lakeshore: 51mm, 4-500 K, gases
- ...

### ✓ ALFNA Noise Analyzer from Keysight

- FET, BJT, Diode, Resistor, Circuit
- Noise Floor:  $2e-27$  A<sup>2</sup>/Hz
- f: 3 mHz – 40 MHz,
- RTN:  $dt_{min}=2.5$  nsec, ...

### ✓ Vector Network Analyzer (s)

- Large-band VNA: 900 Hz-125 GHz, 2 ports
- PNA-X: 26.5 GHz, 4-ports,
- ...

### ✓ Anechoic chamber (400 MHz-40 GHz)

### ✓ PolyTec Vibrometer

### ✓ Semiconductor Analyzers

### ✓ ... and much more (visit our website for details)



# Industry applications

## • What we propose to industry

- ☐ Equipment rent
- ☐ Equipment rent accompanied by training
- ☐ Consultancy
- ☐ Measurement campaign realized by UCLouvain staff/members
- ☐ Customized
- ☐ Training for R&D engineers from industry

## • How it works

- ☐ Signed Conventions (long-term)
- ☐ One-shot service
- ☐ Joint Projects

## • Examples / Business Clients

- ☐ **Solvay (B)**: large-band measurements for materials characterization
- ☐ **Total (B)** : materials tests
- ☐ **SOITEC (Fr)** : SOI substrates
- ☐ **ST-M (Fr), LETI (Fr)**: characterization in a large frequency and T ranges
- ☐ **IMEC (B)**: tests at cryogenic temperatures
- ☐ **Incize (B)**: RF characterization, transmission lines, crosstalk, ...
- ☐ **Thales (B)**: radiation effects on devices and circuits
- ☐ **CommuniThings (B)**: EMC pre-compliance
- ☐ **Alvalux (B)**: opto-electrical measurements
- ☐ **AGC (B)**: automotive smart-glasses characterization
- ☐ **E-peas (B)**: test of  $\mu$ Controllers, Circuitry for IoT, PCB assembly, ...
- ☐ **Icoms (B)**: spectral analysis at 24 GHz
- ☐ ...

## Process & Contact



### Processing :

- Application processing time: *we are very reactive, typically from day(s) to week, depending on specificity of the demand*
- Processing capabilities : *On request*

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